


<b>Search Notes</b>  	<b>Application/Control No.</b>  10573661	<b>Applicant(s)/Patent Under Reexamination</b>  TOKAIRIN ET AL.
	<b>Examiner</b>  Andrew K Bohaty	<b>Art Unit</b>  1786

SEARCHED			
Class	Subclass	Date	Examiner
428	690	4/20/2009	A. K. Bohaty

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Name Search in PALM	4/20/2009	A. K. Bohaty
East search (see search history printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	4/01/2009, 4/20/2009-4/22/2009	A. K. Bohaty
Google NPL search	4/21/2009	A. K. Bohaty
Scirus NPL search	4/21/2009	A. K. Bohaty
Updated east search (see search history printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	10/14/2009	A. K. Bohaty
STN structure search	10/14/2009	A. K. Bohaty
Updated east search (see search history printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	5/25/20106	A. K. Bohaty
Updated east search (see search history printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	1/4/2010-1/5/2010	A. K. Bohaty
Updated STN structure search (see STN transcript)	1/5/2010	A. K. Bohaty
Updated east search (see search history printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	6/3/2011	A. K. Bohaty
Updated STN structure search (see STN transcript)	6/3/2011	A. K. Bohaty

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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